

Applicat	on/Control No.	Applicant(s)/Pate Reexamination	ent under
10/040,6	521	LIM ET AL.	
Examine	r	Art Unit	
Yuhin H	una	2625	

SEARCHED					
Class	Subclass	Date	Examiner		
382	164,165 190,195 220 257-260	1/20/2006	YH		
	279,305				
348	582	1/20/2006	ΥH		
707	6	1/20/2006	YH		
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INI	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			
382	164,165	1/20/2006	YH			
382	220,305	1/20/2006	YH			
707	6	1/20/2006	ΥH			

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST text search (US PG_PUB, USPAT, EPO, JPO, DERWENT, IBM TDB)	1/20/2006	ΥН
АСМ	6/4/2005	ΥH
IEEE Xplore	6/4/2005	ΥH
SPIE	1/13/2006	ΥH
Interference search	1/20/2006	ΥH